Application/Control No. Applicant(s)/Patent Under Reexamination 10/785,423 FLECK ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2618 Janelle N. Young **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY * 02-2002 709/223 US-2002/0023152 Oguchi, Naoki 370/352 US-2004/0114575 06-2004 Morita et al. В 370/230 05-2005 С US-6,891,797 Frouin, Laurent US-D US-Ε US-F US-G USн USı US-J US-Κ US-L м US-FOREIGN PATENT DOCUMENTS **Document Number** Date Name Classification Country Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

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